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F-doping of nanostructured ZnO: a way to modify structural, electronic, and surface properties

This study investigates the influence of direct fluorine gas on nanostructured ZnO as a simple route to anionic doping. The influence on the structure, electronic properties and surface acidity is elucidated with various analytical methods. It is shown that the amount of F incorporation into the structure can be controlled by the synthesis parameters  $(t,\,T,\,p)$ . Moderate F-doping leads to perfectly F-doped ZnO, whereas when exceeding a certain  $p(F_2)$  an unwanted ZnF2 by-phase is formed.







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# F-doping of nanostructured ZnO: a way to modify structural, electronic, and surface properties†

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Polycrystalline ZnO is a material often used in heterogeneous catalysis. Its properties can be altered by the addition of dopants. We used gaseous fluorine  $(F_{2(n)})$  as direct way to incorporate fluoride in ZnO as anionic dopants. Here, the consequences of this treatment on the structural and electronic properties, as well as on the acidic/basic sites of the surface, are investigated. It is shown that the amount of F incorporation into the structure can be controlled by the synthesis parameters (t, T, p). While the surface of ZnO was altered as shown by, e.g., IR spectroscopy, XPS, and STEM/EDX measurements, the F<sub>2</sub> treatment also influenced the electronic properties (optical band gap, conductivity) of ZnO. Furthermore, the Lewis acidity/basicity of the surface was affected which is evidenced by using, e.g., different probe molecules (CO<sub>2</sub>, NH<sub>3</sub>). In situ investigations of the fluorination process offer valuable insights on the fluorination process itself.

## 1 Introduction

ZnO is an extensively studied metal oxide with multiple applications in catalysis or within optoelectronic devices. 1-6 It is commonly employed in heterogeneous catalysis as a support or co-catalyst, for example in Cu/ZnO based systems applied in methanol synthesis<sup>7</sup> or the reverse water-gas shift reaction.<sup>8</sup> ZnO is an intrinsic n-type semiconductor, containing a high concentration of defects, including oxygen vacancies. 9,10 Doping provides a versatile route to engineer the properties of the material. Doping of the cation lattice was shown to affect the structural, electronic, and catalytic properties of ZnO as part of catalytic systems. 11-13 Anionic N-doping of ZnO is applied to create a p-type semiconductor.<sup>14</sup> Here, we present the effects of using fluoride as an anionic dopant for ZnO to increase its n-type character.

In the literature, fluorine doping of oxides has been employed for the manipulation of electronic and optical properties, for example in case of fluorine modified TiO2.15,16

Fluorine doped ZnO has mainly been studied for the application as a transparent conducting oxide and synthesised by methods such as reactive magnetron sputtering<sup>17,18</sup> or chemical vapour deposition.<sup>19</sup> Previous studies have thus focused on the investigation of the F-doped ZnO materials with respect to their optical and electronic properties. 20,21 Further applications of F-doped ZnO thin films include the use as a gas sensing material.22,23 While ZnO for the application in optoelectronics is required to form thin solid layers, in heterogeneous catalysis a high surface area and thus the generation of large amounts of polycrystalline powder is required. Such polycrystalline F-doped ZnO materials have been previously studied with applications in, e.g., photocatalysis. 24 The influence of fluorine treatment on the catalytic properties of the Cu/ZnO system has been subject of a recent study, 25 however, the role of fluorine remains elusive.

In this contribution, we show the impact of direct  $F_{2(g)}$ treatment on ZnO with respect to structural and electronic properties. To control the amount of fluoride in ZnO, different  $F_{2(g)}$  partial pressures were applied with the aim of providing a synthetic pathway to a F-modified nanostructured ZnO. We employ various techniques (XRD, XPS, NEXAFS, SEM-EDX, STEM-EDX, <sup>19</sup>F NMR, EPR and in situ FT-IR) to probe the effect of fluorine doping on the structural and electronic properties of the material. In light of the applicability of this material as a support in heterogeneous catalysis, the surface properties are thoroughly analysed as well (FT-IR, micro-calorimetry and TDS).

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Paper

## 2 Experimental

#### Sample preparation

Zinc oxide was synthesised by precipitation from the nitrate as follows: 357 g of zinc nitrate hexahydrate were dissolved in 500 mL deionised water with 15 mL nitric acid and filled up to give 600 mL solution. A second solution of 339.16 g sodium carbonate in deionised water to give 2 L was prepared. In an automated reactor (LabMax, Mettler-Toledo), 400 mL deionised water were placed, and 20 g min<sup>-1</sup> of the nitrate solution were added for 30 min while the carbonate solution was added to stabilise the pH at 6.5. The mixture was aged for 60 min before the product was filtered and washed twice with 600 mL water until the conductivity of the filtrate was below 0.5 mS cm<sup>-1</sup>. The resulting white powder (zinc hydroxycarbonate) was then dried at 353 K over night before calcining it in a rotating furnace at 603 K (ramp rate 2 K min<sup>-1</sup>, dwell time 3 h) to yield the white zinc oxide powder (called "ZnO" hereafter).

Two samples were fluorinated by application of fluorine gas of differing partial pressures. The needed amount of F2 was calculated based on the stoichiometry of Zn in ZnO for nominal 1 at% and 10 at% of fluorination. The partial pressure of  $F_{2(g)}$ was adjusted with a calibrated volume. The fluorination was conducted at RT, 1 bar (mixed with N2) and for one hour time of reaction. The sample treated with the lower F<sub>2</sub> partial pressure is termed "ZnO\_F1" in the following, and the sample resulting from the treatment using a higher partial pressure "ZnO\_F10", respectively.

Commercial zinc fluoride (anhydrous 99 min%, alfa aesar ZnF<sub>2</sub> 11521, Lot U01C031) was used as a reference.

#### 2.2 X-ray diffraction

The samples were analysed using X-ray diffraction (XRD) on a Bruker AXS D8 Advance II theta/theta diffractometer in Bragg-Brentano geometry using Ni filtered  $Cu_{\alpha 1+2}$  radiation and a position sensitive energy dispersive LynxEye silicon strip detector. Subsequently, the diffractograms were analysed by whole powder pattern fitting, employing the Rietvelt method as implemented in the TOPAS software (Bruker AXS).

### 2.3 UV-vis spectroscopy

Diffuse Reflectance UV-vis spectroscopy was performed on a Cary5000 photospectrometer (Agilent), employing a Praying Mantis Diffuse Reflection Accessory and Reaction Chamber (Harrick) using Spectralon as a white standard. The optical band gap of each sample was determined from the appropriate Tauc plots<sup>26</sup> by linear extrapolation of the absorption edge to zero intensity.

## 2.4 Electron microscopy

Scanning Electron Microscopy (SEM) was performed using a Hitachi S 4800 SEM equipped with a Genesis 4000 Energy Dispersive X-ray (EDX) detector. The microscope was operated at an acceleration voltage of 1.5 kV. EDX spectra were obtained using an acceleration voltage of 5 kV.

For the TEM measurements, a Thermo Fisher Scientific Talos F200X S/TEM was used with an acceleration voltage of 200 kV. STEM measurements were performed using an HAADF detector, and the ChemiSTEM super-X EDX system using four SDD detectors was employed to generate energy dispersive X-ray spectroscopy (EDX) maps.

#### 2.5 Electron paramagnetic resonance

Electron paramagnetic resonance (EPR) measurements of the fluorinated ZnO samples were conducted in quartz tubes (2.9 mm outer diameter). Continuous wave (CW) EPR spectra at X-band frequencies were obtained at room temperature using a Bruker B-ER420 spectrometer upgraded with a Bruker ECS 041XG microwave bridge and a lock-in amplifier (Bruker ER023M). The samples were measured in a Bruker SHQ or TM<sub>110</sub> resonator applying a modulation amplitude of 5 G and a modulation frequency of 100 kHz. All spectra were background corrected by subtracting a spectrum of an empty quartz tube and the signals were normalised to the sample mass.

#### 2.6 Solid state nuclear magnetic resonance

<sup>19</sup>F MAS NMR spectra were recorded on a Bruker AVANCE 400 spectrometer (Larmor frequency 376.4 MHz) using a 2.5 mm magic angle spinning (MAS) probe (Bruker Biospin) and applying a spinning speed of 20 kHz if not otherwise indicated.  $^{19}$ F MAS NMR (I = 1/2) spectra were recorded with a  $\pi/2$  pulse duration of 4.4 µm, a spectrum width of 400 kHz, and a recycle delay of 5 s. Spectral changes for longer recycle delays were checked. Isotropic chemical shifts of 19F are given with respect to the CFCl<sub>3</sub> standard. Background signals of <sup>19</sup>F were completely suppressed with the application of a phase-cycled depth pulse sequence according to Cory and Ritchey.27

#### 2.7 X-ray photoelectron spectroscopy

X-ray photoelectron spectroscopy was performed on pressed pellets of the samples using non-monochromatised Al Ka excitation (1486.6 eV) and a hemispherical analyser (Phoibos 150, SPECS). The standard Au  $4f_{(7/2)}$  and Cu  $2p_{(3/2)}$  procedure was employed to calibrate the binding energy scale, and no correction for charging effects was applied. Elemental compositions were calculated using theoretical cross sections from Yeh and Lindau.<sup>28</sup>

#### 2.8 Conductivity measurements

The contact-free and in situ Microwave Cavity Perturbation Technique (MCPT)<sup>29</sup> was employed to measure the conductivity of the (fluorinated) zinc oxide samples at 503 K in inert gas (N2) as well as hydrogen- (5% H2/N2) and oxygen-containing  $(5\% O_2/N_2)$  conditions.

The gas flow was held constant at 10 mL min<sup>-1</sup>. The resulting data were fitted and corrected to account for the powder samples' filling fractions using an established formalism. 30,31

#### 2.9 NEXAFS

NEXAFS measurements were performed at the UE56-2 PGM-2 beamline at BESSY II/HZB (Berlin, Germany). All measurements were carried out in a stainless steel NAP-XPS chamber

described in detail elsewhere.<sup>32</sup> The samples were pelletised and mounted on a sapphire sample holder between a stainless steel back-plate and a stainless steel lid with a 6 mm hole.

The NEXAFS spectra of these samples were obtained in the total electron yield mode by recording a sample current. The photon-energy resolution was set to 700 meV at the Zn L<sub>3</sub>-edge ( $\approx$ 1020 eV), 400 meV at the F K-edge ( $\approx$ 680 eV) and 250 meV at the O K-edge ( $\approx$  520 eV) The photon energy was calibrated using the Au 4f line. All NEXAFS spectra were normalised to the incident photon flux.

#### 2.10 IR spectroscopy

The fluorine treated ZnO samples were characterised by FTIR and compared to ZnO and ZnF2. The measurements were carried out using a Varian 670 FTIR spectrometer equipped with a MCT detector. The spectra were recorded at a resolution of 2 cm<sup>-1</sup> accumulating 128 scans. Self-supported wafers (area weight of 20-30 mg cm<sup>-2</sup>) were transferred into an IR cell that is connected to a vacuum line and a gas delivery system. Before the spectroscopic measurements, surface impurities on the samples were removed by heating in the IR cell to 240 °C (200 °C in the case of ZnO\_F10) in 50 mbar O2 until the IR spectra did not show any further changes. The presence of oxygen is necessary in order to avoid the formation of donor centres which may obscure changes of the vibrational bands as a result of their intense and broad absorption in the IR range.

After cooling to 25  $^{\circ}\text{C}$  the cell was evacuated and 67 mbar of NH<sub>3</sub> were added. All spectra shown are recorded after evacuation (to remove gas phase NH<sub>3</sub>) and are referenced against a spectrum taken immediately before NH3 addition. For the desorption experiments the cell was heated at a rate of 1 K min<sup>-1</sup>, with spectra taken every 10 K.

In situ spectroscopy was performed by a Vertex 70 FT-IR spectrometer from Bruker® equipped with a MCT detector. The spectra were recorded at a resolution of 0.5 cm<sup>-1</sup> accumulating 100 scans. Self-supporting wafers of 13 mm diameter were placed in an IR cell.33 The sample was heated to 240 °C in vacuum for 10 h in order to remove surface impurities and subsequently treated with O<sub>2</sub> (120 mbar) for 1 h. 43 mbar 10% F<sub>2</sub>/Ar mixture was added to the cell, while simultaneously taking IR spectra in order to monitor the changes to the sample.

## 2.11 Microcalorimetry

The microcalorimetric experiments were performed in a Calvet calorimeter (SETARAM MS70) equipped with a custom-designed high vacuum and gas dosing apparatus, which allows for the dosage of probe molecules within a range of 0.02 mmol and the calculation of the amount of adsorbed molecules. The samples were heated to 240 °C at a rate of 5 K min<sup>-1</sup> in UHV for 1 h dwell time. After degassing, oxidation was performed in 5% O2 for 30 min two times. Thereafter, the cell was cooled to room temperature and pumped to UHV (10<sup>-7</sup> mbar final pressure), placed inside the calorimeter without contact to air, and connected to the microcalorimetric gas adsorption system. CO2 was then dosed stepwise at 30 °C, while recording pressure, adsorption temperature, and heat signals during all dosing steps.

#### 2.12 Thermal desorption spectroscopy

Thermal desorption spectroscopy (TDS) was applied for the temperature programmed desorption of oxygen. For this, a selfconstructed setup which enables the testing of powder samples was used. The setup is equipped with mass flow controllers, an IR-light furnace (Behr IRF 10) and a mass spectrometer (Pfeiffer Vacuum QME 200). The powder sample was placed on a small quartz-glass boat which is placed in a quartz tube (inner diameter of 14 mm, outer diameter of 20 mm, length of 450 mm) located inside the furnace and connected to the system using Ultra Torr vacuum fittings. Afterwards the system was stepwise brought to  $9 \times 10^{-7}$  mbar and directly connected to the mass spectrometer. The surface was treated at 503 K for 2.5 h under reductive atmospheres (5% H<sub>2</sub> in Ar). Subsequently, at 348 K the surface was saturated with double labelled C18O2 at 1 bar. The desorption experiment was conducted at 10<sup>-6</sup> mbar with a heating rate of 25 K min<sup>-1</sup>.

## 3 Results and discussion

### 3.1 Sample designation

The co-precipitated and calcined polycrystalline ZnO powder was directly treated with  $F_{2(g)}$ . By employing two different  $p(F_2)$ , fluoride concentrations within the ZnO sample of 1 and 10 at%, respectively, were targeted. Accordingly, the samples are named as ZnO F1 and ZnO F10. For details about the preparation method, please see the experimental section. As reference samples, the pristine ZnO and commercial ZnF2 were investigated.

#### 3.2 Structural characterisation of fluorine treated ZnO

**3.2.1** Crystal structure. In order to study the effects of  $F_{2(g)}$ treatment on the crystal structure of ZnO, and to reveal the presence of resulting crystalline by-phases in the samples, X-ray diffraction (XRD) was employed. In Fig. 1, we present the X-ray diffraction patterns of ZnO\_F1 and ZnO\_F10, as well as ZnO

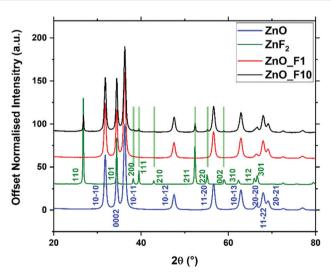


Fig. 1 X-ray diffraction patterns of fluorine treated and untreated ZnO, and commercial ZnF2 as a reference. Indices for ZnO and ZnF2 are given from literature ref. 34 and 35

Table 1 Refined XRD parameters, errors given as 3SD

	a (Å)	c (Å)	z (O)	Size a/c (nm)
ZnO	3.2507(1)	5.2089(2)	0.3808(6)	17.8 (6)/23.9 (6)
ZnO_F1	3.2508(1)	5.2090(2)	0.3810(6)	18.4 (6)/24.0 (6)
ZnO_F10	3.2508(2)	5.2089(3)	0.3815(8)	19.7 (8)/24.4 (8)

and  $ZnF_2$  as references. The XRD pattern is indicative of a hexagonal ZnO phase. The highly fluorinated ZnO\_F10 sample contains in addition  $ZnF_2$  as a by-phase, which is absent in ZnO\_F1.

The whole powder pattern of the fluorinated ZnO samples were fitted (Table 1) to reveal possible changes of the lattice parameters and for the quantification of the  $ZnF_2$ -phase. The fluorination had no impact on the lattice parameters a and c, whereas the oxygen position z(O) increased with increasing fluorine doping. From the Rietveld refinement, the crystalline  $ZnF_2$  by-phase observed for the  $ZnO_F10$  sample amounted to 8 wt% (or  $\sim 6$  at%). The slightly increasing domain size of  $ZnO_F$ , in particular for  $Zn_F10$ , is interpreted as preferential reactivity of  $F_{2(g)}$  with small crystallites to form, e.g.,  $ZnF_2$  moieties.

3.2.2 Quantification of F content. The fluorine content of the fluorine treated samples was quantified using Energy Dispersive X-Ray Spectroscopy (EDX) in the SEM at an information depth of approx. 100 nm. The F/Zn signal ratio was about 10 times lower for the ZnO\_F1 sample than for ZnO\_F10 (F/Zn approx. 0.012 for ZnO\_F1, and *ca.* 0.12 for ZnO\_F10), which matches the expectation based on the applied fluorine pressure and is interpreted as a complete consumption of the  $F_{2(g)}$  in the reaction with ZnO. According to XRD the fluorine bound in ZnF $_2$  is calculated to 6 at%, which means an estimated amount of  $\sim$ 6 at% of fluorine is left in ZnO\_F10 as possible anionic dopant.

Additionally, the surface-near molar element ratios of the samples were investigated using XPS (Table 2). While the total oxygen content measured through the O/Zn ratio remains constant upon fluorine treatment, fitting of the O 1s line shapes reveal a decrease of lattice oxygen content with increasing F-content in the sample. The latter can be interpreted as a substitutional fluorine doping of ZnO upon treatment with gaseous F<sub>2</sub>. Fitting the O1s spectra (Fig. SI1, ESI†) reveals an increase of spectral components with higher binding energy, which points to the fact that the sample with higher F-content contains more absorbed oxygen in the form of OH groups or adsorbed water. This might be a sign for an increased surface Lewis acidity. However, estimating the OH-concentration on the ZnO surface, based on the information depth and calculated

Table 2 Surface-near molar ratios determined by XPS assuming cross sections from ref. 28

	O/Zn	O(lattice)/Zn	F/Zn
ZnO	0.86	0.67	_
ZnO_F1	0.85	0.655	0.023
ZnO_F10	0.86	0.58	0.13
$ZnF_2$	0.12	_	1.67

quantities (Table 2), the coverage is <1 mono layer (ML) without significant influence on the wurtzite lattice. The F 1s spectra show, as expected, a larger F/Zn ratio for ZnO\_F10 than for ZnO\_F1 (Fig. SI4, ESI $\dagger$ ). The slight increase for ZnO in the F 1s region is explained by minor Zn Auger contributions. The stoichiometric disbalance of the O/Zn ratio (<1) is a typical sign for nanostructured ZnO with an oxygen deficient character, originated in the synthesis history of the precursor.

Interestingly, for the ZnO\_F1 sample the F/Zn ratio near the surface (XPS information depth, here:  $\approx 2$  nm) is larger than the bulk F/Zn ratio (determined from EDX/SEM, here:  $\approx 100$  nm). This finding indicates that the concentration of F might be larger near the sample surface.

3.2.3 Morphology and local structure. Complimentary to the integral structural analysis by XRD, the local structure and morphology of the fluorine treated samples was investigated using Scanning Electron Microscopy (SEM) and Transmission Electron Microscopy (TEM), which are not limited to the crystalline part of the samples. Fig. 2(a)–(c) compares the morphology of pristine ZnO to the F-modified ZnO samples. The images feature platelet-type agglomerates with a rough surface. Surprisingly, pure ZnO and the fluoride containing samples look very similar and the microstructure seems to be unaffected by the fluorine treatment. STEM/EDX measurements were employed to further characterise the location of fluorine throughout the sample. The EDX-maps of the elements O and F of the ZnO F1 sample (Fig. 3(a)) reveal a homogeneous fluoride distribution across the sample. The corresponding EDX-spectrum of the region highlighted in (a) (Fig. 3b) confirms the presence of the elements Zn, O, and F. The EDX map of the sample treated with a higher  $p(F_2)$  shows regions exhibiting higher concentrations of fluoride and lower concentrations of oxide, and vice versa. As a consequence, the elements O and F are inhomogeneously distributed within the investigated area. This finding is further illustrated by a line scan given in Fig. 3(d) across the region indicated in (c).

In Fig. 4, a high resolution TEM (HRTEM) image of the same region as Fig. 3(c) is presented along with the fast Fourier transform (FFT) patterns of the indicated regions. The FFTs can be used to identify different crystalline phases present in the sample by referencing the reflections to simulated patterns. These patterns were generated from structures taken from the ICS database (ZnO:<sup>36</sup> 671 330, ZnF<sub>2</sub>:<sup>35</sup> 9169) using the JEMS software.<sup>37</sup> The indexed reflections are given in Fig. SI5 (ESI†). However, as the reflections in (c) are less defined, the radii of the rings on which the reflections are located were used to determine the corresponding lattice plane distances and possible reflections of the two materials. The ring corresponding to a distance of *ca*. 0.26 nm, can be attributed to ZnO 002 and/or ZnF<sub>2</sub> 101.

In both regions indicated in Fig. 4(b) and (c), ZnO was identified as the main structure, but  $ZnF_2$  was found as a minor phase, which agrees well with the results obtained from EDX (Fig. 3(c and d)). Since not all reflections present in Fig. 4(c) correspond to only one of the two phases ZnO and  $ZnF_2$ , along with the results from EDX mapping it can be concluded that this region contains a higher amount of  $ZnF_2$  than region (b).

Fig. 2 SEM images of ZnO (a), ZnO\_F1 (b) and ZnO\_F10 (c).

The results of the electron microscopy investigations are in agreement with the elemental quantifications and structural analysis already discussed. High  $p(F_2)$  was shown to form a heterogeneous system as it leads to the formation of a ZnF2 by-phase, while the low  $p(F_2)$  results in a phase pure system. The spatially heterogeneous distribution observed for the system exposed to high fluorine pressure is readily explained by a ZnF<sub>2</sub> particle adjacent to an F-doped ZnO one.

3.2.4 Nuclear magnetic resonance spectroscopy. The environment of <sup>19</sup>F nuclei within the structure of the fluorine containing samples was investigated by solid state 19 F Nuclear

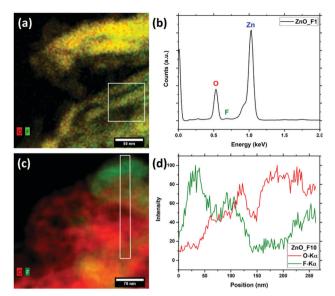
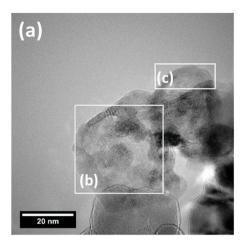


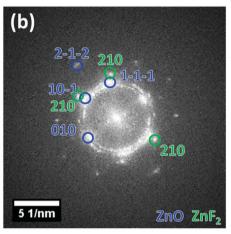
Fig. 3 STEM-EDX of the fluorinated ZnO samples - combined O (red) and F(green) EDX-maps of ZnO\_F1 (a) and ZnO\_F10 (c) as well as EDX spectrum of the marked region of ZnO\_F1 (b) and EDX-line scan of marked region of ZnO\_F10 (d).

Magnetic Resonance (MAS NMR) spectroscopy which is able to identify local environment of 19F species both in crystalline and also potentially X-ray amorphous parts. A comparison of the spectra for all F-containing samples can be found in Fig. 5. In the spectrum of  $ZnF_2$  a <sup>19</sup>F signal at -205 pm is visible (with corresponding spinning sidebands at -88, -150, -258, and -312 ppm (Fig. SI13, ESI†)).

The spectrum of the ZnO\_F10 sample shows a signal at 205 ppm indicating the presence of ZnF<sub>2</sub> in line with the X-ray diffraction results. The variation of the spinning frequency reveals that the signals at -36 ppm, -90 ppm, -255 ppm and -310 ppm are due to spinning side bands. In contrast, the well-resolved signals at -148 ppm and -173 ppm indicating a rather uniform coordination environment of the F-nuclei are not found for crystalline ZnF2. The signals are in the typical region for a fluorine doped oxide (or "fluoro-oxide"), as could be expected for ZnO:F.38

The spectrum of ZnO F1 exhibits a much reduced signal intensity in line with the lower F content, nevertheless the presence of fluorine-related centres is still detectable. The spectrum is characterized by a broad asymmetric line ranging from -150 to -220 ppm. The large width together with the asymmetric line shape gives evidence for a broad distribution of local environments for the fluorine species in this sample. This means, despite a homogeneous spatial distribution of the fluorine within the sample (confirmed by STEM-EDX-maps in Fig. 3(a)), their local arrangements is rather non-uniform (different, non-preferential coordination environments). The spectrum shows narrow signal at -14.8 ppm, which does not disappear in a spin-echo test and is neither found for ZnF2 nor for the ZnO\_F10 sample. It is a typical solid state signal (line width  $\approx 1.5$  kHz) and it appears at the position found for fluorine in BaF2, however, the elemental analysis did not show





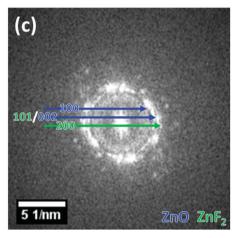


Fig. 4 HR-TEM image of ZnO\_F10 (a) with FFTs of the indicated regions (b) and (c). Selected reflections are indexed in the figure for ZnO (blue) and  $\rm ZnF_2$  (green).

any trace of Ba<sup>2+</sup>. Therefore, we cannot assign this signal unambiguously.

For all three samples, the spin lattice relaxation behaviour of  $^{19}$ F was tested by varying the recycle delay time  $D_1$ . The intensity of the  $^{19}$ F signals is almost unchanged with longer  $D_1$  times for the low fluorine doped sample ZnO\_F1, which is typical for a high degree of disorder of  $^{19}$ F species in the sample. Instead, the  $^{19}$ F signal intensity of prominent signals (-148, -173, and

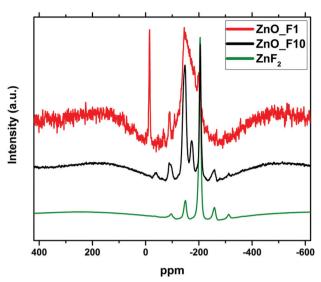


Fig. 5  $\,^{19}\text{F}$  MAS NMR spectra of the fluorinated samples and ZnF $_2$  as a reference. The spectra were recorded with different accumulation numbers (ZnO\_F1; 256, ZnO\_F10: 64, ZnF $_2$ : 32) and have been offset and rescaled for clarity.

-205 ppm; Fig. SI1, ESI†) of the ZnO\_F10 sample shows distinct changes upon varying the  $D_1$  time, which can be considered an additional indication for a homogeneous environment of the fluorine anions. Finally, the amount of fluorine incorporation (1–2 at% for ZnO\_F1 and  $\sim$ 6 at% for ZnO\_F10) might serve as an orientation while interpreting the process of gaseous fluorination as a sequence of doping (without/with preferential coordination environment), saturation and recrystallization (ZnF<sub>2</sub>).

3.2.5 Infrared spectroscopy. The effect of F<sub>2</sub> treatment on the surface of ZnO was studied by IR spectroscopy. The spectra of the untreated ZnO and the two samples treated with different amounts of fluorine gas can be found in Fig. 6, focusing on the bands between 4000 cm<sup>-1</sup> and 3000 cm<sup>-1</sup> (OH stretching region). Overall, an excellent agreement between the spectrum of ZnO to reported values<sup>39</sup> can be noted. In contrast, the spectra of the two fluorinated samples differ from ZnO. The sharp peak assigned to OH on the 0001 surface of ZnO (3620 cm<sup>-1</sup>) shifts to lower energy with increasing degree of fluorination (ZnO\_F1, 3616 cm<sup>-1</sup>; ZnO\_F10 3606 cm<sup>-1</sup>), which indicates a weakening of the OH bond, and thus, a higher acidity.

The bands above  $3670~\rm cm^{-1}$  are assigned to OH stretching modes associated with adsorbed water on the ZnO 1010 facet. These bands are absent for the highly fluorinated sample ZnO\_F10. For ZnO\_F1, the complex line shape becomes more resolved with two dedicated signals at  $3686~\rm cm^{-1}$  and  $3670~\rm cm^{-1}$ , respectively. In addition, the relative intensity of the band assigned to OH groups on the ZnO surface not coupled to co-adsorbed water on this facet ( $3640~\rm cm^{-1}$ ) increases significantly with the degree of fluorination. Therefore, it becomes apparent that the fluorine treatment reduces and finally removes adsorption sites of  $\rm H_2O$  on these facets. Furthermore, broad defect bands at  $3450~\rm cm^{-1}$  and  $3560~\rm cm^{-1}$  are affected. The intensity at  $3450~\rm cm^{-1}$  is reduced while the band

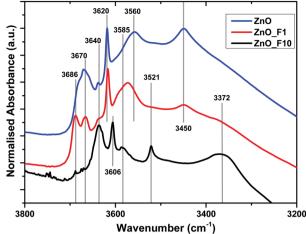


Fig. 6 Normalized IR spectra of ZnO, ZnO\_F1 and ZnO\_F10. The samples were pre-treated in situ at 200 °C in synair to remove moisture.

at 3560 cm<sup>-1</sup> is shifted to higher wavenumbers (from 3560 cm<sup>-1</sup> to 3570 cm<sup>-1</sup>) upon low-pressure fluorination. Upon increasing the degree of fluorination, the band at 3570 cm<sup>-1</sup> shifts to 3585 cm<sup>-1</sup> and loses intensity, whereas the signal at 3450 cm<sup>-1</sup> disappears. Concomitantly, two new features at 3521 cm<sup>-1</sup> and 3372 cm<sup>-1</sup> grow, which can be assigned to OH groups on ZnF2 40 as also evidenced by the XRD and NMR results. The relative ratio between the defect related bands in, e.g., ZnO and ZnO\_F1 changes and becomes for ZnO\_F1 at 3570 cm<sup>-1</sup> and 3585 cm<sup>-1</sup> more intense (or relatively weaker at 3450 cm<sup>-1</sup>). It seems that fluorine occupies parts of the existing intrinsic defect sites like, e.g., vacancies, on the expanse of new ones (extrinsic, fluorine induced). Thus, it appears plausible that fluorine reacts preferably with surface sites coupled to H<sub>2</sub>O or existing defects and subsequently exchanges with oxygen (with the consequence of new F-related defect sites). In addition, our IR spectroscopic insights are in agreement with the XPS results discussed above (increase in surface OH-groups on the expense of lattice oxygen for ZnO F10).

To create a deeper understanding on the ongoing processes of fluorination and fluoride incorporation, in situ reference experiments were conducted. To this end, nanostructured ZnO is treated with F<sub>2(g)</sub> inside the spectrometer cell, and changes relative to the pristine ZnO were monitored as a function of time. Fig. 7 and 8 show the changes for the OH- and the carbonate-region regions of the IR spectrum. The reaction starts instantaneously after the addition of fluorine gas, and the spectrum continuously evolves for several hours. The most significant changes occur in the OH stretching region as already described above (Fig. 6). Upon exposure of the sample to F<sub>2</sub>, the bands at 3690 cm<sup>-1</sup> and 3670 cm<sup>-1</sup>, which are assigned to H<sub>2</sub>O and OH with co-adsorbed water, respectively, both on the ZnO 1010 surface, decline. In contrast, the band at  $\sim 3640 \text{ cm}^{-1}$  increases as a result of the removal of the co-adsorbed water and the possible formation of new OH-groups on former defect sites. This band shifts to 3634 cm<sup>-1</sup> at longer reaction times and with higher degrees of fluorination. Analogous changes are observed for the bands due to

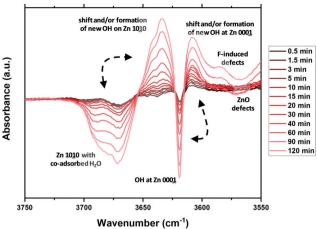


Fig. 7 In situ difference infrared spectra following the fluorine gas treatment of ZnO, relative to the untreated sample (0 min).

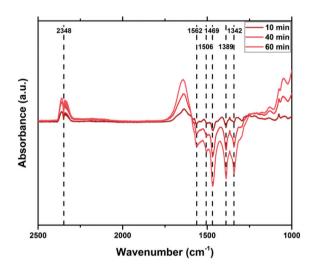


Fig. 8 In situ IR spectra during F2 treatment of ZnO, relative to the untreated sample (0 min).

OH groups on the O-terminated 0001 surface of ZnO. The expected increase at 3616 cm<sup>-1</sup> for ZnO with a low degree of fluorination is masked by the strong decrease of the ZnO related band at 3620 cm<sup>-1</sup>. Instead, an increase at around 3610 cm<sup>-1</sup>, an OH on the 0001 surface of ZnO, is found (shifts to lower wavenumbers, increased acidity). At longer reaction times, the OH vibration band at 3585 cm<sup>-1</sup> which can be assigned to defects becomes visible, in line with a decline of the ZnO defects at 3560 cm<sup>-1</sup> and 3450 cm<sup>-1</sup>. While a quantitative evaluation is not possible due to the strong overlap of bands, a comparison of the water related bands (at 3686 cm<sup>-1</sup>, 3670 cm<sup>-1</sup>) indicate that the former reacts somewhat faster with the provided F2. Furthermore, the OH band related to (extrinsic) defects upon F incorporation (or O substitution) at 3585 cm<sup>-1</sup> is visibly delayed, interpreted as a consecutive reaction. Little difference is observed in how quickly F<sub>2</sub> reacts with the mixed terminated 1010 and the polar terminated 0001 surfaces of ZnO. Concurrent with the changes of the OH stretching vibrations, the formation of gas phase CO2 as well as

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an overall decline of the intensity of the carbonate bands is observed (Fig. 8). Carbonates might be present as trace residuals of the synthesis process or formed on the surface by contact to the ambient. 41 The formation of CO<sub>2</sub> by the replacement of carbonate groups at the ZnO surface by fluoride can be expected to occur according to the following equation:

$$2F_2 + 2CO_3^{\ 2-} \rightarrow 4F^- + 2CO_2 + O_2$$

An increasing amount of gas phase CO2 during fluorination is observed in the spectrum around 2350 cm<sup>-1</sup>. In addition, the band at 1650 cm<sup>-1</sup>, which gains intensity over time, can be assigned to the bending vibration of H<sub>2</sub>O(g), which is in line with a release of co-adsorbed water upon fluorination deduced from the spectra in the OH region, discussed above.

In summary, the IR spectroscopic investigations unravel a couple of changes on the surface of ZnO upon fluorine treatment. The quality and quantity of the OH-groups is significantly altered. OH groups related to co-adsorbed water are gradually decreasing and new OH groups are formed. Besides, some existing OH-groups are shifted to lower energy as a sign for an increased Lewis acidity. No preferential surface termination for fluorination is identified, which might be explained by the overall high reactivity of F<sub>2(g)</sub>. However, the hydroxyl- and carbonate-related functions seem to react faster than the defect related sites, in particular upon the formation of new (extrinsic or F-induced) ones.

### 3.3 Investigation of the electronic properties of fluorine treated ZnO

**3.3.1 Optical band gaps.** The optical band gaps of the fluorine treated and untreated ZnO samples were determined using DR-UV-vis (diffuse reflectance ultraviolet-visible) spectroscopy, and extrapolating the band gap (BG) energies from the appropriate Tauc plots (see Fig. SI14, ESI†). Fig. 9 shows that ZnO and ZnO\_F1 have a similar optical BG, whereas the more fluorinated sample ZnO F10 has a larger optical band gap. Since ZnF<sub>2</sub> is an insulating material, its possible contribution

in ZnO\_F10 is negligible. Interpreting these results in light of the <sup>19</sup>F-NMR results as changes of ZnO moieties by different kinds of ZnO:F doping (quantitative and qualitative), a low level of ZnO:F doping does not affect the shallow donor states near the conduction band (or the F-induced defects at the expense of intrinsic ZnO defects are balanced). In contrast, a high level of ZnO:F (with preferential coordination environment) increases the BG by quenching those sites as consequence of a possible "over-fluorination". The gas phase fluorination of ZnO seems to have a low impact on the bulk properties, respectively, the bulk F-doping of ZnO seems to be small.

3.3.2 Conductivity of the samples in varying gas feeds. Using MCPT, the conductivity of the non-fluorinated and fluorine treated ZnO sample in varying gas feeds (100% N<sub>2</sub>, 5% H<sub>2</sub>/N<sub>2</sub> and 5% O<sub>2</sub>/N<sub>2</sub>) at 503 K was measured. The conductivity of the samples in these gas feeds gives an indication for the interaction of the samples with the gases H<sub>2</sub> and O<sub>2</sub>, and for the reversibility of these processes. Fig. 10 presents the conductivity of ZnO, ZnO F1, and ZnO F10 in these different gas feeds. The x-axis also denotes the sequence in which the gas feeds were applied. Firstly, the fluorinated systems exhibit an enhanced conductivity  $(3\times)$  as compared to the pure ZnO sample. The application of reductive conditions (5% H<sub>2</sub>/N<sub>2</sub>) results in an increase of the conductivity as expected for n-type semiconductors. While the conductivity of the ZnO\_F1 sample increases by more than one order of magnitude, the other two samples show an increase by about a factor of 2 only, which clearly indicates a significant difference in the electronic properties of the two fluorinated systems. Upon switching back to the inert feed the pristine ZnO exhibits a reversible reduction of the conductivity to the initial value. In contrast to that, the conductivity of the fluorinated system remains significantly enhanced as compared to the initial conditions. The extent of the hysteresis is significantly larger for the ZnO\_F1 sample. Applying oxidizing conditions (5%  $O_2/N_2$ ) has little effect on the conductivity of the untreated ZnO sample, whereas the conductivity

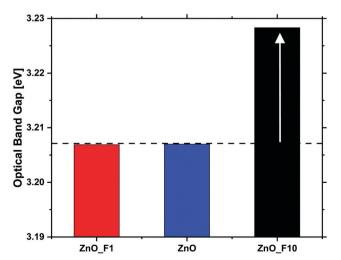


Fig. 9 Optical band gaps of the untreated and fluorine treated ZnO samples as determined by UV-vis spectroscopy

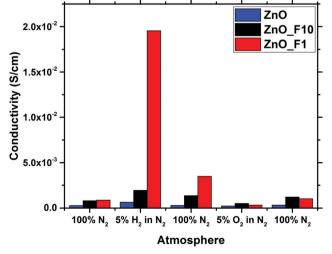


Fig. 10 Conductivity of ZnO, ZnO\_F1 and ZnO\_F10 in different gas feeds determined by MCPT.

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of the fluorinated samples is reduced. The ZnO\_F1 system shows the largest reduction and has a comparable conductivity as the untreated ZnO sample under these conditions. Please note that this is significantly smaller than the one observed under inert conditions. The highly fluorinated sample behaves qualitatively similar to the ZnO F1 sample, however, the extent of the effect is smaller. Upon switching back to inert conditions the fluorinated systems show an increase of the conductivity which becomes similar to their initial values, while the ZnO sample shows little changes. This indicates a qualitative difference between the untreated and F<sub>2</sub> treated samples. While the conductivity of the untreated ZnO can be increased by reductive conditions the effect is reversible already upon switching to inert conditions whereas oxidative treatment has basically no effect on the conductivity.

In contrast to that, the increase of the conductivity upon reductive treatment is significantly larger for both of the fluorinated samples, indicating that the fluorination has altered the electronic properties of the materials. Since the optical band gap of ZnO\_F1 was not affected by the fluorination, this increase in conductivity is rather explained by surface effects. This means that the activation and chemisorption of H<sub>2</sub>, providing/donating the electrons, is significantly enhanced. The changes induced by reduction are only partially reversible under inert conditions in contrast to the pristine ZnO. This indicates that the reduced state of the material is stabilized in case of the fluorinated systems, and that the activated H2 is bound rather weakly. Furthermore, it is interesting to note that an oxidative treatment, which has little effect on the pristine ZnO, reduced the conductivity of the fluorinated systems. This is, however, in line with the weak bonding of hydrogen on ZnO and thus already removed under inert conditions.

3.3.3 Electron paramagnetic resonance. The fluorination of ZnO leads to an enhanced conductivity of the system and significant alterations towards the response to different environments. Thus, it is interesting to gain more insight into the nature of the states that are involved in these changes. Substitutional doping a system with an aliovalent anion will result in states in the band gap. Several of these are paramagnetic and hence, EPR spectroscopy can be used to investigate these species. ZnO was shown to exhibit two major classes of paramagnetic defects observed at g = 1.958 and g = 2.007, which are assigned to shallow donor states and Zn vacancies, respectively. 42 The cw EPR spectra of the untreated and fluorine treated ZnO samples are presented in Fig. 11. Overall, the spectra of ZnO, ZnO\_F1 and ZnO\_F10 are very similar. All samples show a strong, typical ZnO-defect signal around g = 1.958 (359.7 mT). The area of the double integral increases by 1/3 upon low fluorination (ZnO\_F1), but decreases for ZnO\_F10 (also by 1/3), in comparison to ZnO as reference (see inset Fig. 11). The second signal found in ZnO samples (g = 2.007, 351 mT) is almost absent in the spectra of the fluorinated samples. The increase of the defect concentration for the low fluorination level and the subsequent reduction for higher fluorination levels is in line with the NMR observations, which show a very heterogeneous F-environment, and hence,

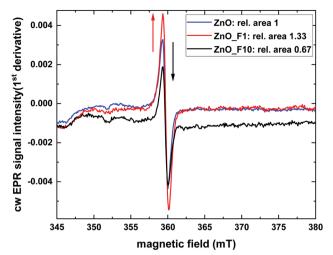


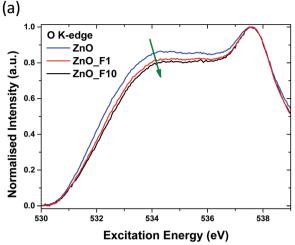
Fig. 11 9.8 GHz cw EPR spectra at room temperature, normalised to catalyst mass

an inhomogeneous perturbation of the lattice for the low fluorination level, while a much more homogenous situation is observed for the higher fluorinated sample.

It is interesting to look for a spatial proximity of the defect centers and the F-anions in the lattice. The latter is possible by scrutinizing the coupling between the paramagnetic states to nuclear spins in its surrounding. To this end pulsed EPR measurements of ZnO\_F1 were performed, which showed no direct coupling of the ZnO defect at g = 1.958 to fluorine nuclei (see Fig. SI15, ESI†). This excludes a simple substitutional F-doping of the oxygen sublattice and an associated trapping of the hole center close by.

While the XPS data provide evidence for a significant degree of hydroxylation of the ZnO surfaces the pulsed EPR spectra show no evidence for a coupling of the paramagnetic states to hydrogen atoms, which renders the corresponding species not to be located in the bulk of the sample. However, due to the limited impact of bulk F-doping (indicated by optical BG measurements), the ZnO-defect signal at g = 1.958 might rather be surface related and further explain the conductivity measurements, which significantly increased for ZnO\_F1. Besides the higher quantity of defect sites for ZnO\_F1, another criterion like surface acidity might influence the H2 activation (and conductivity) and is probed later by NH<sub>3</sub>-IR investigations.

3.3.4 NEXAFS. NEXAFS (Near Edge X-ray Absorption Fine Structure) spectroscopy was used in order to elucidate the density of unoccupied states of the samples ZnO, ZnO\_F1, and ZnO\_F10 near the surface. In ZnO the Zn and O centers are tetrahedrally coordinated. Formally, Zn<sup>2+</sup> in ZnO has 10 d electrons, which completely occupy the 3-t2 and 2-e orbitals and an empty 4s orbital. Studies on various Zn-salts like nitrates or carbonates, show that this picture is oversimplifying. Instead, a hybridization between Zn and O states is observed, which reflects a certain degree of covalence in these systems. The latter is even more pronounced for ZnO.43,44 Following the dipole-transition selection rule,45 the features in the O K-edge spectra (Fig. 12(a)) are excitations related from O 1s to



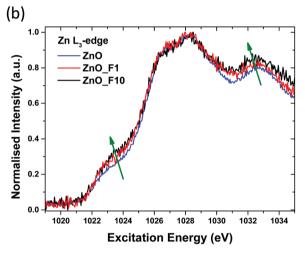


Fig. 12 (a) O K-edge and (b) Zn L-edge of unfluorinated and fluorinated ZnO samples.

unoccupied O 2p states. The series of O K-edge spectra show a constant onset of the signals. Upon fluorination the relative intensity of the signal at 534 eV is reduced as compared to the signal at 537.7 eV. Most of this effect is already present for the ZnO\_F1 sample, while the changes for the ZnO\_F10 sample are small. Substitution of oxygen by fluorine, which has a higher electronegativity, leads to redistribution of electrons. The relative decrease in the density of unoccupied O 2p states (UDOS) with fluorination indicates that fluorine and oxygen are not directly coupled (since fluorine would increase the UDOS), but indirectly via Zn-centres. The decrease in UDOS is thus explained by a less covalent bonding character upon fluorination and a decrease in electron transfer from O 2p into Zn 4d states. The main features in the Zn L<sub>3</sub>-edge (Fig. 12(b)) are related to the excitation from Zn 2p electrons to 4s and 4d states. The increase in Zn L3-edge resonances represents also an increase in UDOS related to the fluorine incorporation on the expense of oxygen. The high electronegativity of fluorine leads to an increased ionic bonding character. This is further supported by an increase of the 2p to 4s transition visible at 1023.5 eV (more unoccupied 4s states) and into hybridized

states (O 2p and likely Zn 4d states) at 1033 eV.  $^{43,44}$  Furthermore, the correlating trends within the O K-edge and Zn L<sub>3</sub>-edge intensities, caused by fluorination, follow the opposite trends observed for N-doped ZnO (p-type doping), where an increase in O K-edge and decrease in Zn L<sub>3</sub>-edge is attributed to an increased covalence by nitrogen incorporation.  $^{14}$  The peak ration change in the O K-edge (534 eV/537.5 eV) and in the Zn L<sub>3</sub>-edge (1023.5 eV/1033 eV) is F substitution at O sites and/or doping into interstitial sites.  $^{43}$  Generally, the changes of the electronic structure upon fluorination seems to be mainly attributed to ZnO:F, since the major impact is already observed for ZnO\_F1. The F K-Edge spectra are given in the ESI† and show the presence of ZnF<sub>2</sub> in the spectrum for ZnO\_F10.  $^{46}$ 

#### 3.4 Surface acid-base properties of fluorine treated ZnO

3.4.1 IR spectroscopic analysis of the surface acidity probed by NH3 adsorption. The NEXAFS data indicate an increased ionicity of the system. In turn, this may change the Lewis acidity of the cationic sites on the surface. The latter can be probed by the changes in the vibrational spectrum of appropriate adsorbates. NH<sub>3</sub> was shown to be such a probe for Lewis acidity of surface sites. Fig. 13(a) shows the IR spectra of the three samples (ZnO, ZnO\_F1 and ZnO\_F10) after NH3 adsorption, all relative to the respective pristine samples. With increasing fluorine content in the sample, the symmetric NH<sub>3</sub> bending vibration, as sensitive probe for the coordination environment, shifts from 1209 cm<sup>-1</sup> in ZnO to 1221 cm<sup>-1</sup> in ZnO\_F1 and finally to 1225 cm<sup>-1</sup> in ZnO\_F10. This shift is explained by an increase in the electron deficient character of Zn cations in the samples. 47-49 In our case, the increase of the Lewis acidity in Zn cations is caused by the fluorination of the samples.50 Furthermore, ZnO\_F10 shows an additional band at 1268 cm<sup>-1</sup>, which is already present as a weak feature in the

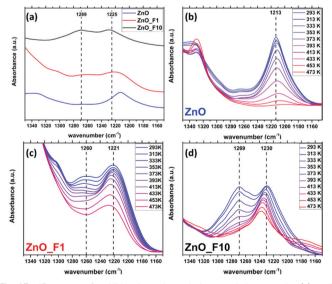


Fig. 13 IR spectra after  $NH_3$  adsorption relative to pristine samples (a), and spectra taken during  $NH_3$  temperature programmed desorption of ZnO (b), ZnO\_F1 (c) and ZnO\_F10 (d). For reference, dashed lines in (a) are given at 1225 cm $^{-1}$  and 1269 cm $^{-1}$ .

spectrum of ZnO\_F1 (tiny signal for ZnO). The range in which this band appears is typical for NH<sub>3</sub> adsorbed on a very electron poor adsorption site in other transition metal oxides, (e.g., V<sub>2</sub>O<sub>5</sub> at 1270 cm<sup>-1 49,51</sup> and MoO<sub>3</sub> at 1260 cm<sup>-1 49</sup>). From a comparison with the IR spectrum of ZnF2 after NH3 adsorption (Fig. SI17, ESI†), the band cannot be assigned to adsorption sites on ZnF2 particles. Thus, it is likely that this band is also associated with an electron poor adsorption site, which is already present on ZnO in low concentrations. The concentration of such adsorption sites (defects) in fluorinated samples increases and possibly represents a Zn cation in a particularly fluoride enriched (likely ordered) environment.

Temperature programmed IR spectra (Fig. 13(b)-(d)) were measured to elucidate the adsorption strength of NH3 on the different adsorption sites. The stability of the weakly perturbed sites in ZnO\_F1 and ZnO\_F10 (1221 cm<sup>-1</sup> and 1230 cm<sup>-1</sup>) is significantly enhanced (compared to ZnO at 1213 cm<sup>-1</sup>). The bands at 1260-1269 cm<sup>-1</sup>, related to Zn cations likely in a fluoride rich and ordered environment, decline more rapidly than the bands at 1221 cm<sup>-1</sup> (ZnO\_F1) and 1230 cm<sup>-1</sup> (ZnO\_F10), respectively. This might be an indication that an additional stabilisation (e.g., by neighbouring OH groups) of the adsorbed molecule on the highly Lewis acidic and fluorine enriched sites is absent (or present for the sites at 1209–1230 cm<sup>-1</sup>). However, the latter bands have a gradually increased stability with the degree of fluorination and Lewis acidity, also visible at the residual intensity at 473 K for, e.g., ZnO\_F10. This might further explain the higher conductivity values under hydrogen atmosphere, since Lewis acid sites are known to be relevant for H2 activation (and here electron donation).52

3.4.2 Analysis of the surface basicity probed by  $CO_2$ . The Lewis basicity of adsorption sites was studied using the adsorption enthalpy of CO<sub>2</sub> as probed by microcalorimetry.<sup>53</sup> In Fig. 14, the amount of adsorbed CO2 on ZnO and ZnO\_F1 are

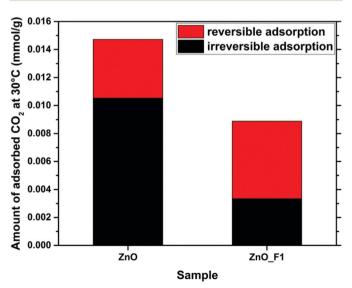


Fig. 14 Adsorption of CO<sub>2</sub> on the surfaces of ZnO and ZnO\_F1. The reversible and irreversible contributions to the total adsorption are indicated.

shown. The total amount of adsorbed CO2 is reduced by about 1/3 when comparing ZnO and ZnO\_F1. In particular, the amount of irreversibly adsorbed CO2 is reduced by a factor of 3.1, while the amount of reversibly adsorbed CO<sub>2</sub> is increasing for the ZnO F1 sample as compared to pure ZnO. It becomes evident that fluorination reduces the adsorption strength of CO<sub>2</sub> on the sample surface from 80 kJ mol<sup>-1</sup> to 60 kJ mol<sup>-1</sup> (initial differential heat of adsorption, Fig. SI18(a), ESI†). In fact, no significant adsorption of this gas could be observed for ZnO\_F10 or ZnF<sub>2</sub> (see Fig. SI18(b), ESI†). The relative amount of irreversibly adsorbed CO2 on ZnO and ZnO\_F1 was further investigated by thermal desorption spectroscopy (TDS). The m/z = 48 desorption signal is shown in Fig. SI19 (ESI†). The desorption spectra of both samples are qualitatively almost identical and exhibit several desorption features separated by significant temperature. This indicates that fluorine treatment does not alter the nature of the adsorption sites for CO2 significantly. Quantitatively, the number of adsorption sites on the fluorinated sample is reduced by a factor of 2.7, which compared favourably with the microcalorimetry (factor of 3.1). The loss in basic adsorption sites is in line with the expectation based on the increased Lewis acidity of the surface (s.a.) as both properties are generally found to be inversely correlated.

## 4 Conclusions and final discussion

In this contribution, we have presented the direct treatment of ZnO with  $F_{2(g)}$  as a convenient way to modify both the electronic properties and the surface structure of ZnO. Hereby, the degree of fluorine incorporation into the sample can be controlled by variation of the synthesis parameters (partial pressure of F<sub>2</sub>, residence time of the fluorine gas on the sample). The time resolved fluorination indicates a kinetically controlled reaction of  $F_{2(g)}$  with ZnO. In situ IR spectroscopy obtained during this reaction showed that fluorine removes carbonates on the ZnO surface and displaces adsorbed water, possibly by changing the interaction strength of the surface with H2O through replacement of O by F. No preferred ZnO surface termination with respect to their fluorine interaction was identified. The OH groups, also related to defect sites, were found to be altered in the spectrum as well. The treatment resulted in two types of fluorine modified sample: ZnO F1 shows a spatially homogeneous distribution of fluorine throughout the sample, as evidenced by STEM/EDX mapping and its crystal structure shows only peaks that can be assigned to ZnO (in line with a possible F-doping of this material). In contrast, ZnO\_F10, resulting from treatment of ZnO with a higher partial pressure of F2, resulted in "over-fluorination" as indicated by the appearance of a ZnF2 by-phase. This is demonstrated by NMR and X-ray diffraction and underlined by the agglomeration of F near the particle surface in the EDX map presented. In addition, the 19F-NMR experiments reveal as function of the fluorine content two different kinds of ZnO:F doping: In the low F-doping regime (1–2 at%) a rather heterogeneous coordination environment (see broad 19F-NMR signals) and a well ordered

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coordination with higher degree of doping (until 6 at%). A combination of XRD, NMR, EPR and in situ IR studies identifies the fluorination as intriguing process where F is very likely locates on lattice and interstitial sites. The substitution of lattice oxygen seems to be the primary process, since F-induced defect sites are detectable only delayed, as possible consecutive adaption of the structure. Comparing the F/Zn ratios of surfacenear and bulk sensitive methods, a homogeneous surface enrichment of fluorine for ZnO\_F1 and a heterogeneous for ZnO\_F10 is indicated. This behaviour is to be expected for samples resulting from gas-solid-reactions and is currently under investigation for ZnO single crystals as part of a separate study.

In both samples, the F2 treatment affected the electronic properties and the interaction of the sample with various gaseous probe molecules. Adsorption of NH3 and CO2 as Lewisacidic and -basic probes, respectively, revealed, in the IR spectra of the samples and in the microcalorimetry investigation, that the Lewis basic sites in ZnO were quenched, while the Lewis acidity of the surface increased incrementally with the F-content. As a consequence, the interaction of the samples with CO<sub>2</sub> was greatly reduced, as confirmed by microcalorimetry and TDS. Hereby, the fluorinated samples differed significantly in their behaviour, with ZnO\_F10 showing an interaction with CO<sub>2</sub> close to ZnF<sub>2</sub> (and close to zero). Furthermore, using conductivity as an indicator, we showed that the less fluorinated ZnO F1 showed a drastic increase in conductivity (and consequently in H2 activation) as compared to untreated ZnO and the sample with a higher F-content. Generally, with the degree of fluorination the surface Lewis acidity (on the expense of basicity) is gradually increased as monitored by IR and various probe molecules. The electronic properties, however, are mainly affected by the F-doping, evidenced by DRUVS, NEXAFS and conductivity measurements. This is explained by a combination of more defect sites near the surface (EPR) and a higher Lewis acidity (NH3-IR). The increase of the Lewis acidity alone seems not to be sufficient to increase the conductivity significantly (see ZnO\_F10). Within an attempt to understand the complex processes upon fluorination, the <sup>19</sup>F MAS NMR experiments serve as important bridge between these parts, identifying that nature and consequence of the occurring doping might also be different (at different levels of F-incorporation). Based on the numerous applied methods, the complexity of the nanostructured ZnO and relevant processes upon fluorination are identified and in parts unravelled. The impact of different local arrangements on, e.g., the surface properties has to be investigated within a separated DFT study.

Since ZnO often finds application as part of a CO<sub>2</sub> reduction catalyst, these findings suggest that the catalytic performance of catalysts derived from fluorine treated ZnO may be influenced significantly.<sup>25</sup> Hereby, an "over-fluorination" might result in a rather inactive catalyst, while a sample with a lower F-content (i.e. moderately doped ZnO:F) may improve the catalytic performance due to the interaction of this material with H<sub>2</sub> and its dual site character of the surface (acid/basic surface sites). Further work on this sample system will be conducted in order to investigate the limits of F-doping without

the formation of the ZnF<sub>2</sub> by-phase, as well as the catalytic performance in CO2 reduction of ZnO:F adding a metal component.

## Conflicts of interest

There are no conflicts to declare.

## Acknowledgements

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## Notes and references

- 1 G. Wang, X. Yang, F. Qian, J. Z. Zhang and Y. Li, Nano Lett., 2010, 10, 1088-1092.
- 2 X. Zhang, J. Qin, Y. Xue, P. Yu, B. Zhang, L. Wang and R. Liu, Sci. Rep., 2015, 4, 4596.
- 3 R. Schölin, M. Quintana, E. M. J. Johansson, M. Hahlin, T. Marinado, A. Hagfeldt and H. Rensmo, J. Phys. Chem. C, 2011, 115, 19274-19279.
- 4 L. E. Greene, M. Law, J. Goldberger, F. Kim, J. C. Johnson, Y. Zhang, R. J. Saykally and P. Yang, Angew. Chem., Int. Ed., 2003, 42, 3031-3034.
- 5 Z. R. Tian, J. A. Voigt, J. Liu, B. Mckenzie, M. J. Mcdermott, M. A. Rodriguez, H. Konishi and H. Xu, Nat. Mater., 2003, 2,
- 6 Y. J. Xing, Z. H. Xi, Z. Q. Xue, X. D. Zhang, J. H. Song, R. M. Wang, J. Xu, Y. Song, S. L. Zhang and D. P. Yu, Appl. Phys. Lett., 2003, 83, 1689-1691.
- 7 T. Lunkenbein, F. Girgsdies, T. Kandemir, N. Thomas, M. Behrens, R. Schlögl and E. Frei, Angew. Chem., Int. Ed., 2016, 55, 12708-12712.
- 8 C. Álvarez Galván, J. Schumann, M. Behrens, J. L. G. Fierro, R. Schlögl and E. Frei, Appl. Catal., B, 2016, 195, 104-111.
- 9 M. B. Fichtl, J. Schumann, I. Kasatkin, N. Jacobsen, M. Behrens, R. Schlögl, M. Muhler and O. Hinrichsen, Angew. Chem., Int. Ed., 2014, 53, 7043-7047.
- 10 I. Beinik, M. Hellström, T. N. Jensen, P. Broqvist and J. V. Lauritsen, Nat. Commun., 2015, 8845.
- 11 J. Schumann, M. Eichelbaum, T. Lunkenbein, N. Thomas, M. C. Álvarez Galván, R. Schlögl and M. Behrens, ACS Catal., 2015, 3260-3270.
- 12 J. Schumann, T. Lunkenbein, A. Tarasov, N. Thomas, R. Schlögl and M. Behrens, ChemCatChem, 2014, 6, 2889-2897.
- 13 M. Behrens, G. Lolli, N. Muratova, I. Kasatkin, M. Hävecker, R. Naumann D'Alnoncourt, O. Storcheva, K. Köhler,

**15**, 1374–1381.

- M. Muhler and R. Schlögl, Phys. Chem. Chem. Phys., 2013,
- 14 M. Wang, F. Ren, J. Zhou, G. Cai, L. Cai, Y. Hu, D. Wang, Y. Liu, L. Guo and S. Shen, Sci. Rep., 2015, 5, 12925.
- 15 A. M. Czoska, S. Livraghi, M. Chiesa, E. Giamello, S. Agnoli, G. Granozzi, E. Finazzi, C. Di Valentin and G. Pacchioni, J. Phys. Chem. C, 2008, 112, 8951-8956.
- 16 E. M. Samsudin and S. B. Abd Hamid, Appl. Surf. Sci., 2017, **391**, 326-336.
- 17 X. Noirfalise, T. Godfroid, G. Guisbiers and R. Snyders, Acta Mater., 2011, 59, 7521-7529.
- 18 R. E. Treharne and K. Durose, Thin Solid Films, 2011, 519, 7579-7582
- 19 H. Liang and R. G. Gordon, J. Mater. Sci., 2007, 42, 6388-6399.
- 20 P. M. Ratheesh Kumar, C. Sudha Kartha, K. P. Vijayakumar, F. Singh and D. K. Avasthi, Mater. Sci. Eng., B, 2005, 117, 307-312.
- 21 R. Gonzalez-Hernandez, A. I. Martinez, C. Falcony, A. A. Lopez, M. I. Pech-Canul and H. M. Hdz-Garcia, Mater. Lett., 2010, 64, 1493-1495.
- 22 E. Şennik, S. Kerli, Ü. Alver and Z. Z. Öztürk, Sens. Actuators, B, 2015, 216, 49-56.
- 23 E. Gunasekaran, M. Ezhilan, G. K. Mani, P. Shankar, A. J. Kulandaisamy, J. B. B. Rayappan and K. J. Babu, Semicond. Sci. Technol., 2018, 33, 095005.
- 24 M. W. Kadi, D. McKinney, R. M. Mohamed, I. A. Mkhalid and W. Sigmund, Ceram. Int., 2016, 42, 4672-4678.
- 25 V. Dybbert, S. M. Fehr, F. Klein, A. Schaadt, A. Hoffmann, E. Frei, E. Erdem, T. Ludwig, H. Hillebrecht and I. Krossing, Angew. Chem., Int. Ed., 2019, 1-6.
- 26 J. Tauc, Mater. Res. Bull., 1968, 3, 37-46.
- 27 D. G. Cory and W. M. Ritchey, J. Magn. Reson., 1988, 80, 128-132.
- 28 J. J. Yeh and I. Lindau, At. Data Nucl. Data Tables, 1985, 32, 1-155.
- 29 M. Eichelbaum, R. Stösser, A. Karpov, C.-K. Dobner, F. Rosowski, A. Trunschke and R. Schlögl, Phys. Chem. Chem. Phys., 2012, 14, 1302-1312.
- 30 D. C. Dube, J. Phys. D: Appl. Phys., 1970, 3, 1648-1652.
- 31 H. Looyenga, Physica, 1965, 31, 401-406.
- 32 A. Knop-Gericke, E. Kleimenov, M. Hävecker, R. Blume, D. Teschner, S. Zafeiratos, R. Schlögl, V. I. Bukhtiyarov, V. V. Kaichev, I. P. Prosvirin, A. I. Nizovskii, H. Bluhm, A. Barinov, P. Dudin and M. Kiskinova, Adv. Catal., 2009, 52, 213-272.

- 33 R. Farra, M. García-Melchor, M. Eichelbaum, M. Hashagen, W. Frandsen, J. Allan, F. Girgsdies, L. Szentmiklósi, N. López and D. Teschner, ACS Catal., 2013, 3, 2256-2268.
- 34 Y.-N. Xu and W. Y. Ching, Phys. Rev. B: Condens. Matter Mater. Phys., 1993, 48, 4335-4351.
- 35 W. H. Baur and A. A. Khan, Acta Crystallogr., Sect. B: Struct. Crystallogr. Cryst. Chem., 1971, 27, 2133-2139.
- 36 S. C. Abrahams and J. L. Bernstein, Acta Crystallogr., Sect. B: Struct. Crystallogr. Cryst. Chem., 1969, 25, 1233-1236.
- 37 P. A. Stadelmann, *Ultramicroscopy*, 1987, 21, 131–146.
- 38 G. Scholz, C. Stosiek, J. Noack and E. Kemnitz, J. Fluorine Chem., 2011, 132, 1079-1085.
- 39 H. Noei, H. Qiu, Y. Wang, E. Löffler, C. Wöll and M. Muhler, Phys. Chem. Chem. Phys., 2008, 7092-7097.
- 40 Y. Guo, S. Wuttke, A. Vimont, M. Daturi, J. C. Lavalley, K. Teinz and E. Kemnitz, J. Mater. Chem., 2012, 22, 14587-14593.
- 41 J. Strunk, K. Kähler, X. Xia and M. Muhler, Surf. Sci., 2009, 603, 1776-1783.
- 42 G. P. Papari, B. Silvestri, G. Vitiello, L. De Stefano, I. Rea, G. Luciani, A. Aronne and A. Andreone, J. Phys. Chem. C, 2017, 121, 16012-16020.
- 43 J. W. Chiou, J. C. Jan, H. M. Tsai, C. W. Bao, W. F. Pong, M.-H. Tsai, I.-H. Hong, R. Klauser, J. F. Lee, J. J. Wu and S. C. Liu, Appl. Phys. Lett., 2004, 84, 3462-3464.
- 44 P. J. Møller, S. A. Komolov and E. F. Lazneva, J. Phys.: Condens. Matter, 1999, 11, 9581-9588.
- 45 J. G. Chen, Surf. Sci. Rep., 1997, 30, 1-152.
- 46 T. Yamamoto, T. Mizoguchi, K. Tatsumi, I. Tanaka, H. Adachi, Y. Muramatsu, E. M. Gullikson and R. C. C. Perera, Mater. Trans., 2004, 45, 1991-1993.
- 47 J. K. Wilmshurst, Can. J. Chem., 1960, 38, 467-472.
- 48 G. F. Svatos, D. M. Sweeny, S.-I. Mizushima, C. Curran and J. V. Quagliano, Infrared Spectrosc. Adsorbed Species Surf. Transit. Met. Oxides, 1957, 3313-3315.
- 49 A. A. Davydov, Infrared Spectroscopy of Adsorbed Species on the Surface of Transition Metal Oxides, John Wiley & Sons, Chichester, 1990.
- 50 F. Yin, A. L. Blumenfeld, V. Gruver and J. J. Fripiat, J. Phys. Chem. B, 1997, 101, 1824-1830.
- 51 A. A. Davydov, Kinet. Catal., 1993, 34, 803-808.
- 52 J. Nováková, L. Kubelková and P. Jírů, J. Chem. Soc., Faraday Trans. 1, 1981, 77, 1331-1339.
- 53 M. M. Millet, G. Algara-Siller, S. Wrabetz, A. Mazheika, F. Girgsdies, D. Teschner, F. Seitz, A. Tarasov, S. V. Levchenko, R. Schlögl and E. Frei, J. Am. Chem. Soc., 2019, 141, 2451-2461.